

# SILICON TRANSISTOR 2SC3582

# MICROWAVE LOW NOISE AMPLIFIER NPN SILICON EPITAXIAL TRANSISTOR

#### **DESCRIPTION**

The 2SC3582 is an NPN epitaxial silicon transistor designed for use in low-noise and small signal amplifiers from VHF band to UHF band. Low-noise figure, high gain, and high current capability achieve a very wide dynamic range and excellent linearity. This is achieved by direct nitride passivated base surface process (DNP process) which is an NEC proprietary new fabrication technique.

#### **FEATURES**

NF 1.2 dB TYP. @f = 1.0 GHz
Ga 12 dB TYP. @f = 1.0 GHz

#### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Collector to Base Voltage	Vсво	20	V
Collector to Emitter Voltage	VCEO	10	V
Emitter to Base Voltage	Vево	1.5	V
Collector Current	Ic	65	mΑ
Total Power Dissipation	Рт	600	mW
Junction Temperature	$T_j$	150	°C
Storage Temperature	Tstg	-65 to +150	°C

**PACKAFE DIMENSIONS** in millimeters (inches) 5.2 MAX. (0.204 MAX.) (0.216 MAX. 14 MIN. (0.551 MIN.) 0.5 (0.02) 2.54 WAX. (0.1) TAM MAX. 1.27 (0.05)0.165 MAX.) 4.2 MAX. 1. Base EIAJ : SC-43B 2. Emitter JEDEC: TO-92 Collector IEC : PA33

ELECTRICAL CHARACTERISTICS (TA = 25 °C)

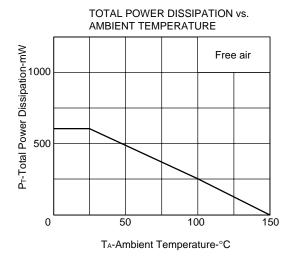
ELECTRICAL CHARACTERISTICS (TA = 25°C)							
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Collector Cutoff Current	Ісво			1.0	μА	VcB = 10 V, IE = 0	
Emitter Cutoff Current	ІЕВО			1.0	μΑ	V <sub>EB</sub> = 1 V, I <sub>C</sub> = 0	
DC Current Gain	hfe	50	100	250		Vce = 8 V, Ic = 20 mA	
Gain Bandwidth Product	f⊤		8		GHz	VcE = 8 V, Ic = 20 mA	
Feed-Back Capacitance	Cre		0.4	0.9	pF	VcB = 10 V, IE = 0, f = 1.0 MHz	
Insertion Power Gain	S <sub>21e</sub>   <sup>2</sup>	9	11		dB	VcE = 8 V, Ic = 20 mA, f = 1.0 GHz	
Maximum Available Gain	MAG		13		dB	VcE = 8 V, Ic = 20 mA, f = 1.0 GHz	
Noise Figure	NF		1.2	2.5	dB	VcE = 8 V, IE = 7 mA, f = 1.0 GHz	

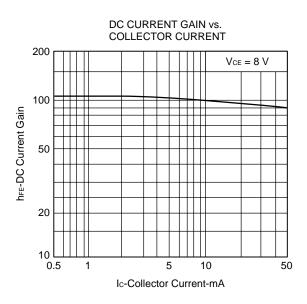
#### hee Classification

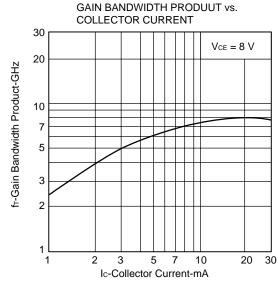
TIFE CIASSITICATION					
Class	К				
Marking	К				
hfe	50 to 250				

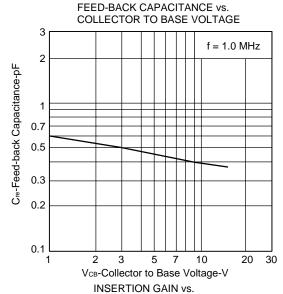


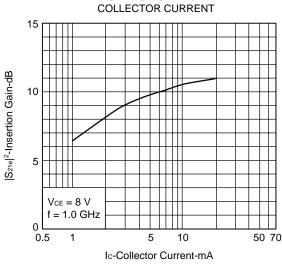
## TYPICAL CHARACTERISTICS (TA = 25 °C)

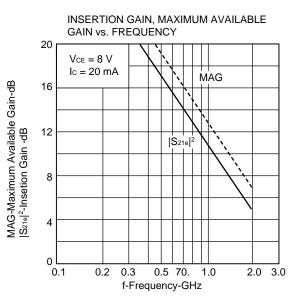


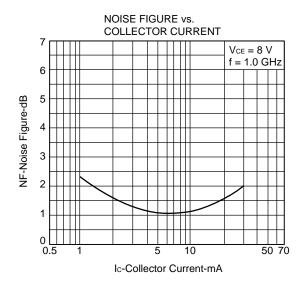












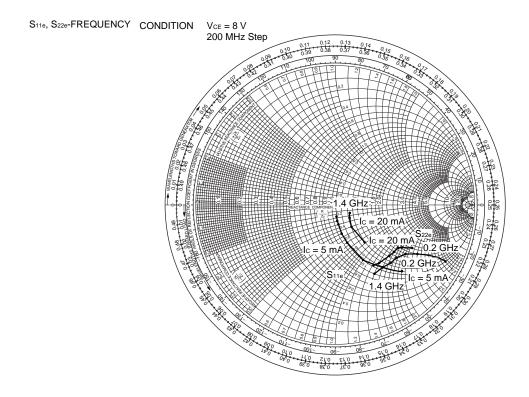
# **S-PARAMETER**

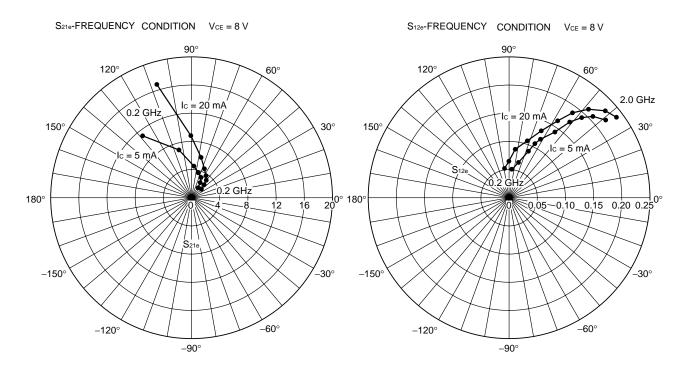
 $\mbox{Vce}$  = 8.0 V, Ic = 5.0 mA, Zo = 50  $\Omega$ 

200 0.668 -45.8 11.385 128.9 0.049 83.5 0.833   400 0.425 -61.5 7.014 103.7 0.063 76.3 0.681   600 0.294 -73.2 5.189 88.6 0.088 68.5 0.620	-26.9 -31.1 -36.0 -40.8 -46.3
600 0.294 -73.2 5.189 88.6 0.088 68.5 0.620	-36.0 -40.8 -46.3
	-40.8 -46.3
	-46.3
800 0.214 -79.4 3.967 75.4 0.103 64.5 0.580	
1000 0.167 -79.5 3.485 64.7 0.123 60.8 0.561	<b>50</b> 4
1200 0.132 -79.8 2.831 57.0 0.147 55.9 0.549	-53.4
1400 0.098 -75.2 2.604 48.5 0.175 50.7 0.561	-60.3
1600 0.073 -72.0 2.182 39.1 0.192 47.9 0.573	-69.1
1800 0.071 -63.7 2.135 31.0 0.215 44.2 0.595	-71.8
2000 0.070 -60.6 1.879 21.6 0.221 38.0 0.617	-78.0
$V_{CE}$ = 8.0 V, $I_{C}$ = 20 mA, $Z_{O}$ = 50 $\Omega$	
f (MHz) $ S_{11} $ $\angle S_{11}$ $ S_{21} $ $\angle S_{21}$ $ S_{12} $ $\angle S_{12}$ $ S_{22} $	∠ <b>S</b> 22
200 0.333 -51.4 17.197 107.7 0.053 97.5 0.638	-29.7
400 0.195 -49.2 8.729 89.7 0.064 90.1 0.585	-31.8
600 0.158 -44.3 6.149 78.8 0.078 80.3 0.573	-35.0
800 0.156 -41.0 4.603 68.7 0.111 70.0 0.549	-38.2
1000 0.146 -35.8 3.997 60.4 0.136 64.2 0.537	-42.4
1200 0.143 -30.7 3.205 54.1 0.168 58.1 0.524	-57.1
1400 0.134 -25.8 2.939 46.7 0.185 53.2 0.524	-55.4
1600 0.132 -22.3 2.463 38.1 0.218 47.3 0.524	-62.0
1800 0.131 -20.0 2.396 30.7 0.234 41.3 0.557	-68.5
2000 0.130 -17.8 2.107 22.1 0.238 36.5 0.579	-74.8

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## **S-PARAMETER**





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Anti-radioactive design is not implemented in this product.

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